

SW3N90U-VB TO251 Datasheet

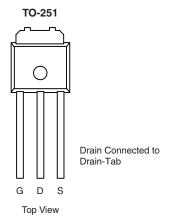
Power MOSFET

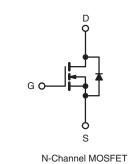
PRODUCT SUMMARY					
V _{DS} (V)	950				
R _{DS(on)} (Ω)	V _{GS} = 10 V 5.4				
Q _g (Max.) (nC)	78				
Q _{gs} (nC)	10				
Q _{gd} (nC)	42				
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER			SYMBOL	LIMITE	UNIT	
Drain-Source Voltage			V _{DS}	950	V	
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$	1-	3.6			
	VGS at 10 V	T _C = 100 °C	ID	2.3	A	
Pulsed Drain Current ^a			I _{DM}	14		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ	
Repetitive Avalanche Current ^a			I _{AR}	3.6	А	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	Peak Temperature) for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in	
Mounting Torque				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 36 mH, $R_g = 25 \Omega$, $I_{AS} = 3.6 \text{ A}$ (see fig. 12). c. $I_{SD} \le 3.6 \text{ A}$, dl/dt $\le 70 \text{ A/}\mu\text{s}$, $V_{DD} \le 600$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

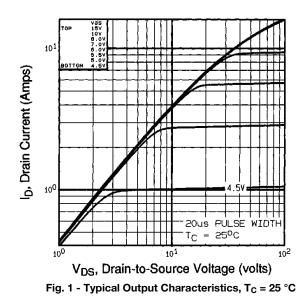
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	950	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	1.1	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
		V _{DS} =	= 900 V, V _{GS} = 0 V	-	-	100	μA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 720 V	/, V _{GS} = 0 V, T _J = 125 °C	-	-	500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.2 A ^b	-	5.4	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	100 V, I _D = 2.2 A ^b	2.3	-	-	S
Dynamic		·					
Input Capacitance	C _{iss}		V _{GS} = 0 V, V _{DS} = 25 V,		1200	-	
Output Capacitance	C _{oss}				320	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	200	-	1
Total Gate Charge	Qg			-	-	78	nC
Gate-Source Charge	Q_gs	V _{GS} = 10 V	$I_D = 3.6 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13^{b}	-	-	10	
Gate-Drain Charge	Q _{gd}		See lig. 6 and 16	-	-	42	
Turn-On Delay Time	t _{d(on)}				14	-	- ns
Rise Time	t _r	$V_{DD} = 450 \text{ V}, \text{ I}_{D} = 3.6 \text{ A},$ $\text{R}_{g} = 12 \ \Omega, \text{ R}_{D} = 120 \ \Omega, \text{ see fig. } 10^{\text{b}}$		-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	90	-	
Fall Time	t _f			-	30	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	·				•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.6	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	14	
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 3.6 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = 3.6 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.4	2.1	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

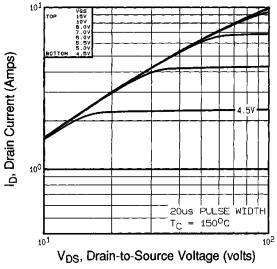


Fig. 2 -Typical Output Characteristics, $T_C = 150$ °C

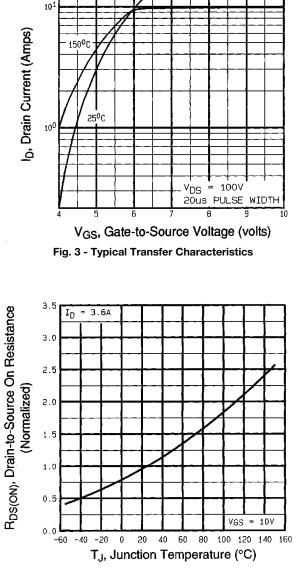


Fig. 4 - Normalized On-Resistance vs. Temperature



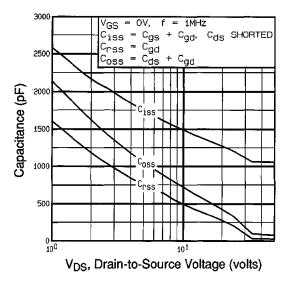


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

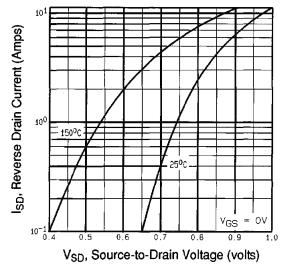


Fig. 7 - Typical Source-Drain Diode Forward Voltage

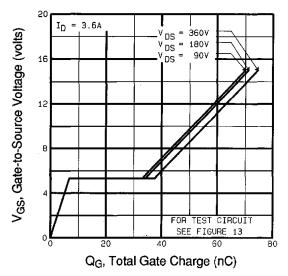
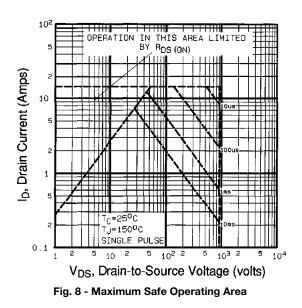


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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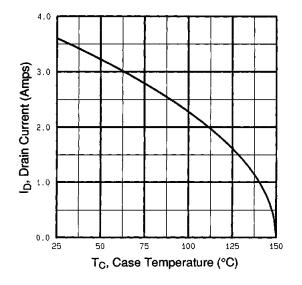


Fig. 9 - Maximum Drain Current vs. Case Temperature

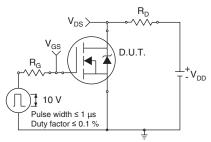


Fig. 10a - Switching Time Test Circuit

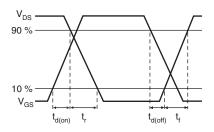
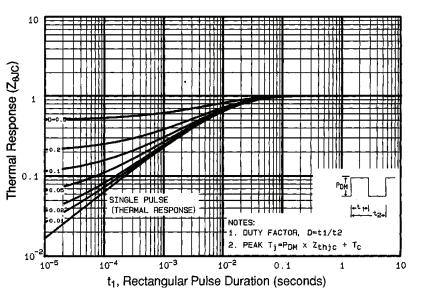


Fig. 10b - Switching Time Waveforms





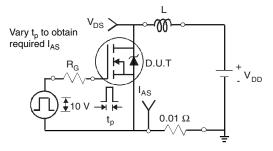


Fig. 12a - Unclamped Inductive Test Circuit

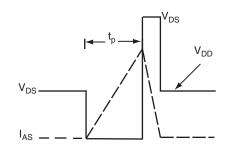


Fig. 12b - Unclamped Inductive Waveforms



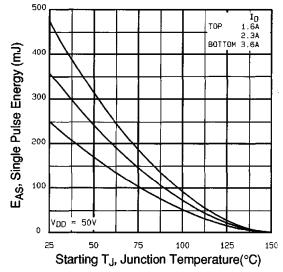


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

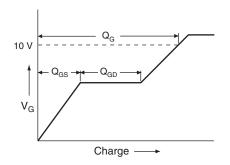


Fig. 13a - Basic Gate Charge Waveform

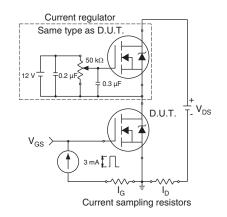
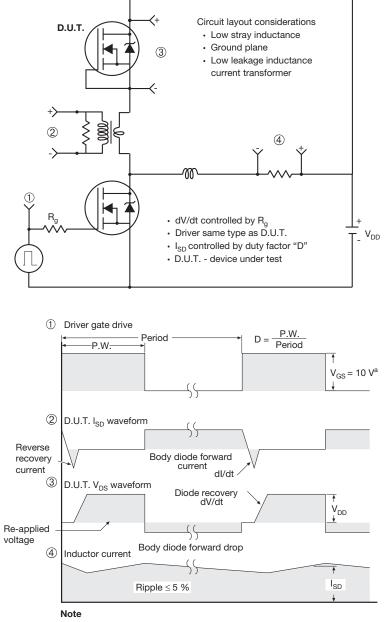


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



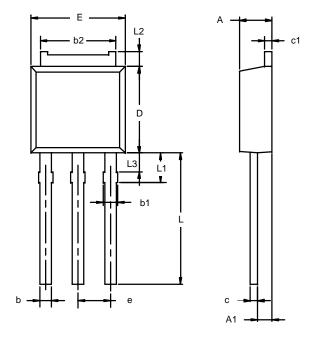
a. $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

SW3N90U-VB TO251



TO-251AA



	MILLIN	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
c1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
E	6.48	6.73	0.255	0.265	
е	2.28	BSC	0.090	BSC	
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	

Note: Dimension L3 is for reference only.



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